











LMP2021, LMP2022

SNOSAY9G-SEPTEMBER 2008-REVISED FEBRUARY 2016

# LMP202x Zero-Drift, Low-Noise, EMI-Hardened Amplifiers

### **Features**

(Typical Values,  $T_A = 25$ °C,  $V_S = 5$  V)

- Input Offset Voltage (Typical) -0.4 µV
- Input Offset Voltage (Max) ±5 µV
- Input Offset Voltage Drift (Typical) -0.004 µV/°C
- Input Offset Voltage Drift (Max) ±0.02 µV/°C
- Input Voltage Noise,  $A_V = 1000 \ 11 \ nV/\sqrt{Hz}$
- Open Loop Gain 160 dB
- CMRR 139 dB
- PSRR 130 dB
- Supply Voltage Range 2.2 V to 5.5 V
- Supply Current (per Amplifier) 1.1 mA
- Input Bias Current ±25 pA
- GBW 5 MHz
- Slew Rate 2.6 V/µs
- Operating Temperature Range -40°C to 125°C
- 5-Pin SOT-23, 8-Pin VSSOP and 8-Pin SOIC **Packages**

# 2 Applications

- **Precision Instrumentation Amplifiers**
- **Battery Powered Instrumentation**
- Thermocouple Amplifiers
- **Bridge Amplifiers**

# 3 Description

The LMP2021 and LMP2022 are single and dual precision operational amplifiers offering ultra low input offset voltage, near zero input offset voltage drift, very low input voltage noise and very high open loop gain. They are part of the LMP™ precision family and are ideal for instrumentation and sensor interfaces.

The LMP202x has only 0.004 µV/°C of input offset voltage drift, and 0.4 µV of input offset voltage. These attributes provide great precision in high accuracy applications.

The proprietary continuous auto zero correction circuitry ensures impressive CMRR and PSRR, removes the 1/f noise component, and eliminates the need for calibration in many circuits.

With only 260 nV<sub>PP</sub> (0.1 Hz to 10 Hz) of input voltage noise and no 1/f noise component, the LMP202x are suitable for low frequency applications such as industrial precision weigh scales. The extremely high open loop gain of 160 dB drastically reduces gain error in high gain applications. With ultra precision DC specifications and very low noise, the LMP202x are ideal for position sensors, bridge sensors, pressure sensors, medical equipment and other high accuracy applications with very low error budgets.

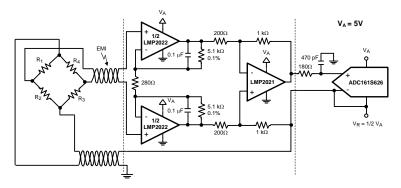
The LMP2021 is offered in 5-Pin SOT-23 and 8-Pin SOIC packages. The LMP2022 is offered in 8-Pin VSSOP and 8-Pin SOIC packages.

# Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
LMP2021	SOIC (8)	4.90 mm x 3.91 mm		
	SOT-23 (5)	2.90 mm x 1.60 mm		
LMP2022	SOIC (8)	4.90 mm x 3.91 mm		
	VSSOP (8)	3.00 mm x 3.00 mm		

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### **Bridge Amplifier**



The LMP202x support systems with up to 24 bits of accuracy.



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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

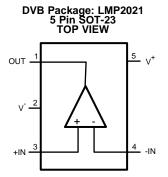
С	anges from Revision F (December 2014) to Revision G Pag			
•	Deleted SC-70 and VSSOP references from LMP2021 pinout descriptions	3		
<u>.</u>	Deleted DCK and DGK packages and corrected SOT-23 pin function table for LMP2021	3		
С	hanges from Revision E (March 2013) to Revision F	Page		
•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	1		
С	hanges from Revision D (March 2013) to Revision E	Page		
•	Changed layout of National Data Sheet to TI format	23		

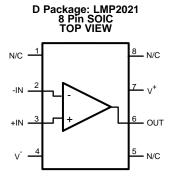
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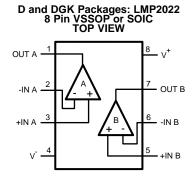
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# 5 Pin Configuration and Functions







## Pin Functions: LMP2021

	PIN			
	LMP2021		1/0	DESCRIPTION
NAME	DBV	D		
OUT	1	6	I	Output
+IN			I	Non-Inverting Input
-IN			0	Inverting Input
V-	2	4	Р	Negative Supply
V+	5	7	Р	Positive Supply
N/C	-	1	-	No Internal Connection
N/C - 5		-	No Internal Connection	
N/C	-	8	-	No Internal Connection

#### **Pin Functions: LMP2022**

	PIN				
	LMP2022		LMP2022	1/0	DESCRIPTION
NAME	D, DGK		D_CON.II NOIN		
+IN A	3	-	Non-Inverting input, channel A		
+IN B	5	- 1	Non-Inverting input, channel B		
−IN A	2	_	Inverting input, channel A		
–IN B	6	I	Inverting input, channel B		
OUT A	1	0	Output, channel A		
OUT B	7	0	Output, channel B		
V+	8	Р	Positive (highest) power supply		
V–	4	Р	Negative (lowest) power supply		

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# 6 Specifications

# 6.1 Absolute Maximum Ratings(1)(2)

		MIN	MAX	UNIT
V <sub>IN</sub> Differential		-V <sub>S</sub>	$V_S$	
Supply Voltage (V <sub>S</sub> =	: V <sup>+</sup> - V <sup>-</sup> )		6.0	٧
All Other Pins		V <sup>+</sup> + 0.3	V <sup>-</sup> - 0.3	٧
Output Short-Circuit	Duration to V <sup>+</sup> or V <sup>-(3)</sup>		5	seconds
Junction Temperatur	e <sup>(4)</sup>		150	°C
Soldering	Infrared or Convection (20 sec)		235	°C
Information	Wave Soldering Lead Temperature (10 sec)		260	ů
T <sub>stg</sub>	Storage temperature range	-65	150	°C

<sup>(1)</sup> Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Recommended Operating Conditions indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications and the test conditions, see the Electrical Characteristics Tables.

- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
- (3) Package power dissipation should be observed.
- (4) The maximum power dissipation is a function of  $T_{J(MAX)}$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any ambient temperature is  $P_D = (T_{J(MAX)} T_A)/\theta_{JA}$ . All numbers apply for packages soldered directly onto a PC board.

## 6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	±2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±1000	V
		Machine model	±200	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

# 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
Temperature Range	-40	125	°C
Supply Voltage $(V_S = V^+ - V^-)$	2.2	5.5	V

### 6.4 Thermal Information

	(1)	LMP2021, LMP2022	LMP2021	LMP2022	
	THERMAL METRIC <sup>(1)</sup>	D	DBV	DGK	UNIT
		8 PINS	5 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	106	164	217	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



# 6.5 Electrical Characteristics: 2.5 V<sup>(1)</sup>

Unless otherwise specified, all limits are ensured for  $T_A = 25^{\circ}C$ ,  $V^+ = 2.5$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $R_L > 10$  k $\Omega$  to  $V^+/2$ .

	PARAMETER		TEST CONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
Vos	Input Offset Voltage			-5	-0.9	5	.,
		-40°C	S ≤ T <sub>J</sub> ≤ 125°C	-10		10	μV
TCV <sub>OS</sub>	Input Offset Voltage Drift <sup>(4)</sup>			-0.02	0.001	0.02	μV/°C
I <sub>B</sub>	Input Bias Current			-100	±23	100	<b>~</b> ^
		-40°C	S ≤ T <sub>J</sub> ≤ 125°C	-300		300	рA
Ios	Input Offset Current			-200	±57	200	pА
		-40°C	40°C ≤ T <sub>J</sub> ≤ 125°C			250	pΑ
CMRR	Common Mode Rejection Ratio	-0.2 \	$/ \le V_{CM} \le 1.7 \text{ V}, 0 \text{ V} \le V_{CM} \le 1.5 \text{ V}$	105	141		
		-0.2 \ -40°C	$V \le V_{CM} \le 1.7 \text{ V}, 0 \text{ V} \le V_{CM} \le 1.5 \text{ V},$ $V \le V_{CM} \le 1.5 \text{ C}$	102			dB
CMVR	Input Common-Mode Voltage	Large	Signal CMRR ≥ 105 dB	-0.2		1.7	
	Range	Large 125°C	Signal CMRR ≥ 102 dB, −40°C ≤ T <sub>J</sub> ≤	0		1.5	V
EMIRR	Electro-Magnetic Interference Rejection Ratio <sup>(5)</sup>		$V_{RF-PEAK} = 100 \text{ mV}_P \text{ (-20 dBV}_P)$ f = 400 MHz		40		
		IN+	$V_{RF-PEAK} = 100 \text{ mV}_{P} (-20 \text{ dBV}_{P})$ f = 900 MHz		48		dB
		and IN-	$V_{RF-PEAK} = 100 \text{ mV}_{P} (-20 \text{ dBV}_{P})$ f = 1800 MHz		67		
			$V_{RF-PEAK} = 100 \text{ mV}_{P} (-20 \text{ dBV}_{P})$ f = 2400 MHz		79		
PSRR	Power Supply Rejection Ratio	2.5 V	$\leq V^{+} \leq 5.5 \text{ V}, V_{CM} = 0$	115	130		
			$\leq V^{+} \leq 5.5 \text{ V}, V_{CM} = 0, -40^{\circ}\text{C} \leq \text{T}_{\text{J}} \leq$	112			dB
		$2.2 \text{ V} \le \text{V}^+ \le 5.5 \text{ V}, \text{ V}_{CM} = 0$		110	130		
A <sub>VOL</sub>	Large Signal Voltage Gain	$R_L = 10 \text{ k}\Omega \text{ to V}^+/2, V_{OUT} = 0.5 \text{ V to 2 V}$		124	150		
		$R_L$ = 10 kΩ to V <sup>+</sup> /2, $V_{OUT}$ = 0.5 V to 2 V, -40°C ≤ $T_J$ ≤ 125°C		119			
		$R_L = 2 k\Omega \text{ to V}^+/2, V_{OUT} = 0.5 V \text{ to 2 V}$		120	150		dB
		$R_L = 2$	$\frac{2}{5}$ kΩ to V <sup>+</sup> /2, V <sub>OUT</sub> = 0.5 V to 2 V, $\frac{1}{5}$ ≤ T <sub>J</sub> ≤ 125°C	115			
V <sub>OUT</sub>	Output Swing High	R <sub>L</sub> = '	0 kΩ to V+/2		38	50	
		$R_L = 1$	0 kΩ to V <sup>+</sup> /2, −40°C ≤ T <sub>J</sub> ≤ 125°C			70	
		$R_1 = 2 k\Omega \text{ to } V^+/2$			62	85	mV
		$R_L = 2 k\Omega$ to V <sup>+</sup> /2, -40°C ≤ $T_J$ ≤ 125°C				115	
	Output Swing Low	R <sub>L</sub> = '	0 kΩ to V <sup>+</sup> /2		30	45	
		$R_L = 1$	0 kΩ to V <sup>+</sup> /2, −40°C ≤ T <sub>J</sub> ≤ 125°C			55	
		$R_L = 2$	2 kΩ to V <sup>+</sup> /2		58	75	
		$R_L = 2$	$2 kΩ to V^{+}/2, -40°C ≤ T_J ≤ 125°C$			95	
I <sub>OUT</sub>	Linear Output Current	Source	ing, V <sub>OUT</sub> = 2 V	30	50		m^
		Sinkin	g, V <sub>OUT</sub> = 0.5 V	30	50		mA

<sup>(1)</sup> Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T<sub>J</sub> = T<sub>A</sub>. No specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where T<sub>J</sub> > T<sub>A</sub>.

<sup>(2)</sup> All limits are specified by testing, statistical analysis or design.

<sup>(3)</sup> Typical values represent the most likely parametric norm at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

<sup>(4)</sup> Offset voltage temperature drift is determined by dividing the change in V<sub>OS</sub> at the temperature extremes by the total temperature change.

<sup>(5)</sup> The EMI Rejection Ratio is defined as EMIRR = 20Log ( $V_{RF-PEAK}/\Delta V_{OS}$ ).



# Electrical Characteristics: 2.5 V<sup>(1)</sup> (continued)

Unless otherwise specified, all limits are ensured for  $T_A = 25^{\circ}C$ ,  $V^+ = 2.5$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $R_L > 10$  k $\Omega$  to  $V^+/2$ .

	PARAMETER	TEST CONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT	
I <sub>S</sub>	Supply Current	Per Amplifier		0.95	1.10	A	
		Per Amplifier, –40°C ≤ T <sub>J</sub> ≤ 125°C			1.37	mA	
SR	Slew Rate <sup>(6)</sup>	$A_V = +1, C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$ $V_O = 2 \text{ V}_{PP}$		2.5		V/µs	
GBW	Gain Bandwidth Product	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		5		MHz	
G <sub>M</sub>	Gain Margin	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		10		dB	
ФМ	Phase Margin	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		60		deg	
C <sub>IN</sub>	Input Capacitance	Common Mode		12		~F	
		Differential Mode		12		pF	
e <sub>n</sub>	Input-Referred Voltage Noise	f = 0.1 kHz or 10 kHz, A <sub>V</sub> = 1000	11			->///	
	Density	f = 0.1 kHz or 10 kHz, A <sub>V</sub> = 100		15		nV/√Hz	
	Input-Referred Voltage Noise	0.1 Hz to 10 Hz		260		-1/	
		0.01 Hz to 10 Hz		330		$nV_PP$	
In	Input-Referred Current Noise	f = 1 kHz		350		fA/√Hz	
t <sub>r</sub>	Recovery time	to 0.1%, $R_L = 10 \text{ k}\Omega$ , $A_V = -50$ , $V_{OUT} = 1.25 \text{ V}_{PP}$ Step, Duration = 50 µs		50		μs	
СТ	Cross Talk	LMP2022, f = 1 kHz		150		dB	

<sup>(6)</sup> The number specified is the average of rising and falling slew rates and is measured at 90% to 10%.



# 6.6 Electrical Characteristics: 5 V<sup>(1)</sup>

Unless otherwise specified, all limits are ensured for  $T_A = 25^{\circ}C$ ,  $V^+ = 5$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $R_L > 10$  k $\Omega$  to  $V^+/2$ .

	PARAMETER		TEST CONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
Vos	Input Offset Voltage			<b>-</b> 5	-0.4	5	
		-40°C	C ≤ T <sub>J</sub> ≤ 125°C	-10		10	μV
TCV <sub>OS</sub>	Input Offset Voltage Drift <sup>(4)</sup>			-0.02	-0.004	0.02	μV/°C
I <sub>B</sub>	Input Bias Current			-100	±25	100	pА
		-40°C	C ≤ T <sub>J</sub> ≤ 125°C	-300		300	
Ios	Input Offset Current			-200	±48	200	<b>~</b> ^
		-40°C	C ≤ T <sub>J</sub> ≤ 125°C	-250		250	pA
CMRR	Common Mode Rejection Ratio	-0.2 \	$V \le V_{CM} \le 4.2 \text{ V}, 0 \text{ V} \le V_{CM} \le 4.0 \text{ V}$	120	139		
			$V \le V_{CM} \le 4.2 \text{ V}, 0 \text{ V} \le V_{CM} \le 4.0 \text{ V},$ $C \le T_J \le 125^{\circ}\text{C}$	115			dB
CMVR	Input Common-Mode Voltage	Large	Signal CMRR ≥ 120 dB	-0.2		4.2	
	Range	Large ≤ 125	Signal CMRR ≥ 115 dB, −40°C ≤ T <sub>J</sub> °C	0		4.0	V
EMIRR	Electro-Magnetic Interference Rejection Ratio <sup>(5)</sup>		$V_{RF-PEAK} = 100 \text{ mV}_P \text{ (-20 dBV}_P)$ f = 400 MHz		58		
		IN+	V <sub>RF-PEAK</sub> = 100 mV <sub>P</sub> (-20 dBV <sub>P</sub> ) f = 900 MHz		64		
		and IN-	V <sub>RF-PEAK</sub> = 100 mV <sub>P</sub> (-20 dBV <sub>P</sub> ) f = 1800 MHz		72		dB
			$V_{RF-PEAK} = 100 \text{ mV}_{P} \text{ (-20 dBV}_{P})$ f = 2400 MHz		82		
PSRR	Power Supply Rejection Ratio	2.5 V	≤ V <sup>+</sup> ≤ 5.5 V, V <sub>CM</sub> = 0	115	130		
		2.5 V 125°C	$\leq$ V <sup>+</sup> $\leq$ 5.5 V, V <sub>CM</sub> = 0, $-40^{\circ}$ C $\leq$ T <sub>J</sub> $\leq$	112			dB
		2.2 V	$\leq V^{+} \leq 5.5 \text{ V}, \text{ V}_{CM} = 0$	110	130		
A <sub>VOL</sub>	Large Signal Voltage Gain	$R_L = 1$	10 kΩ to V <sup>+</sup> /2, $V_{OUT}$ = 0.5 V to 4.5 V	125	160		
		R <sub>L</sub> = 7	10 kΩ to V <sup>+</sup> /2, V <sub>OUT</sub> = 0.5 V to 4.5 V, C ≤ T <sub>J</sub> ≤ 125°C	120			-10
		$R_L = 2 k\Omega$ to V <sup>+</sup> /2, $V_{OUT} = 0.5 V$ to 4.5 V		123	160		dB
		$R_L = 2 \text{ k}\Omega \text{ to V}^+/2, V_{OUT} = 0.5 \text{ V to } 4.5 \text{ V}, \\ -40^{\circ}\text{C} \le T_J \le 125^{\circ}\text{C}$		118			
V <sub>OUT</sub>	Output Swing High	$R_L = 1$	10 kΩ to V <sup>+</sup> /2		83	135	
		$R_L = 1$	10 kΩ to V <sup>+</sup> /2, –40°C ≤ T <sub>J</sub> ≤ 125°C			170	
		$R_L = 2$	2 kΩ to V <sup>+</sup> /2		120	160	
		$R_L = 2$	2 kΩ to V <sup>+</sup> /2, $-40^{\circ}$ C ≤ T <sub>J</sub> ≤ 125°C			204	mV
	Output Swing Low	$R_L = 10 \text{ k}\Omega \text{ to V}^+/2$			65	80	from either rail
			$R_L = 10 \text{ k}\Omega \text{ to V}^+/2, -40^{\circ}\text{C} \le T_J \le 125^{\circ}\text{C}$			105	
		$R_L = 2 k\Omega$ to V <sup>+</sup> /2			103	125	
		$R_L = 2 kΩ$ to V <sup>+</sup> /2, -40°C ≤ $T_J$ ≤ 125°C				158	
I <sub>OUT</sub>	Linear Output Current	Sourc	sing, V <sub>OUT</sub> = 4.5 V	30	50		mΛ
		Sinkir	ng, V <sub>OUT</sub> = 0.5 V	30	50		mA

<sup>(1)</sup> Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T<sub>J</sub> = T<sub>A</sub>. No specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where T<sub>J</sub> > T<sub>A</sub>.

<sup>(2)</sup> All limits are specified by testing, statistical analysis or design.

<sup>(3)</sup> Typical values represent the most likely parametric norm at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

<sup>(4)</sup> Offset voltage temperature drift is determined by dividing the change in V<sub>OS</sub> at the temperature extremes by the total temperature change.

<sup>(5)</sup> The EMI Rejection Ratio is defined as EMIRR = 20Log ( $V_{RF-PEAK}/\Delta V_{OS}$ ).



# Electrical Characteristics: 5 V<sup>(1)</sup> (continued)

Unless otherwise specified, all limits are ensured for  $T_A = 25$ °C,  $V^+ = 5$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $R_L > 10$  k $\Omega$  to  $V^+/2$ .

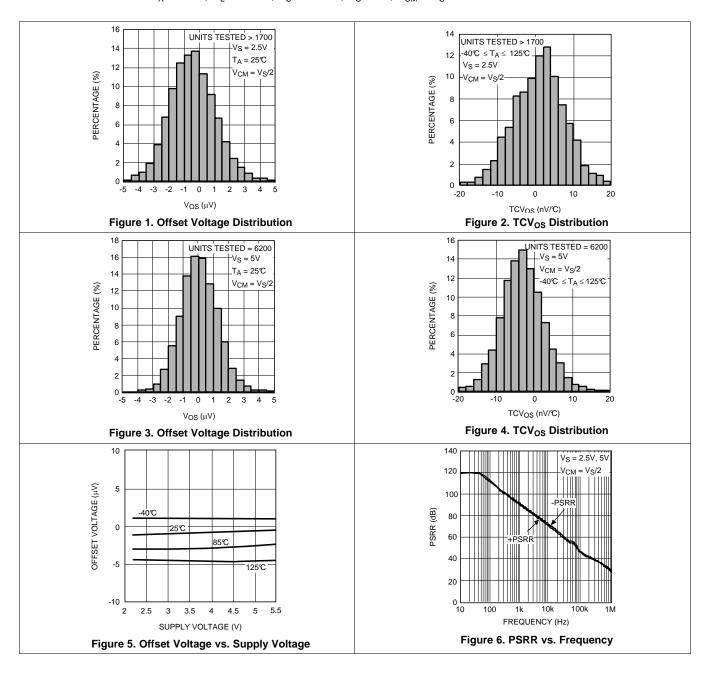
	PARAMETER	TEST CONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
Is	Supply Current	Per Amplifier		1.1	1.25	A
		Per Amplifier, –40°C ≤ T <sub>J</sub> ≤ 125°C			1.57	mA
SR	Slew Rate <sup>(6)</sup>	$A_V = +1, C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$ $V_O = 2 \text{ V}_{PP}$		2.6		V/µs
GBW	Gain Bandwidth Product	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		5		MHz
G <sub>M</sub>	Gain Margin	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		10		dB
ФМ	Phase Margin	$C_L = 20 \text{ pF}, R_L = 10 \text{ k}\Omega$		60		deg
C <sub>IN</sub>	Input Capacitance	Common Mode		12		~F
		Differential Mode		12		pF
e <sub>n</sub>	Input-Referred Voltage Noise	f = 0.1 kHz or 10 kHz, A <sub>V</sub> = 1000		11		nV/√ <del>Hz</del>
	Density	$f = 0.1 \text{ kHz or } 10 \text{ kHz}, A_V = 100$		15		NV/VHZ
	Input-Referred Voltage Noise	0.1 Hz to 10 Hz Noise		260		-1/
		0.01 Hz to 10 Hz Noise		330		$nV_PP$
In	Input-Referred Current Noise	f = 1 kHz		350		fA/√Hz
t <sub>r</sub>	Input Overload Recovery time	to 0.1%, $R_L = 10 \text{ k}\Omega$ , $A_V = -50$ , $V_{OUT} = 2.5 \text{ V}_{PP}$ Step, Duration = 50 μs		50		μs
СТ	Cross Talk	LMP2022, f = 1 kHz		150		dB

<sup>(6)</sup> The number specified is the average of rising and falling slew rates and is measured at 90% to 10%.



# 6.7 Typical Characteristics

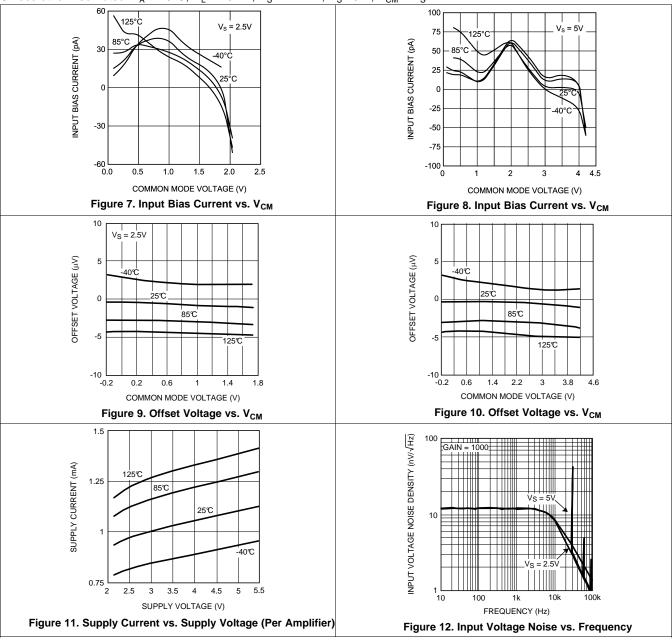
Unless otherwise noted:  $T_A = 25$ °C,  $R_L > 10$  k $\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5$  V,  $V_{CM} = V_S/2$ .



Product Folder Links: LMP2021 LMP2022

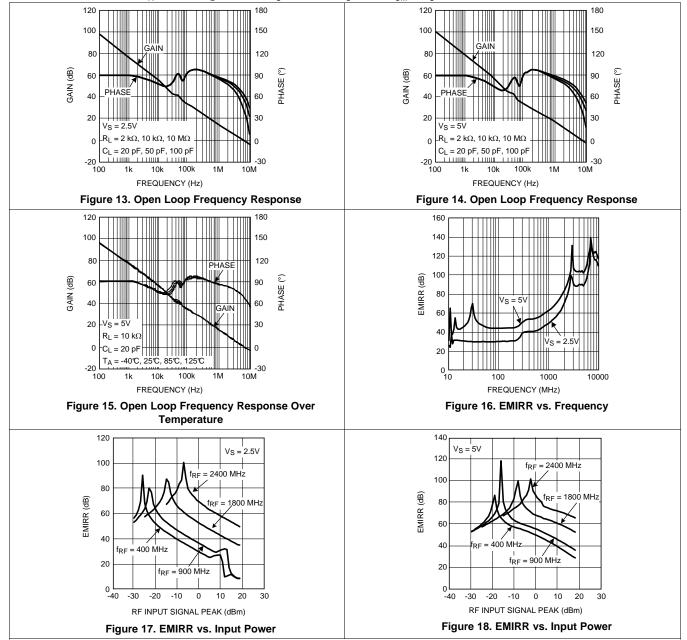


Unless otherwise noted:  $T_A = 25$ °C,  $R_L > 10$  k $\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5$  V,  $V_{CM} = V_S/2$ .





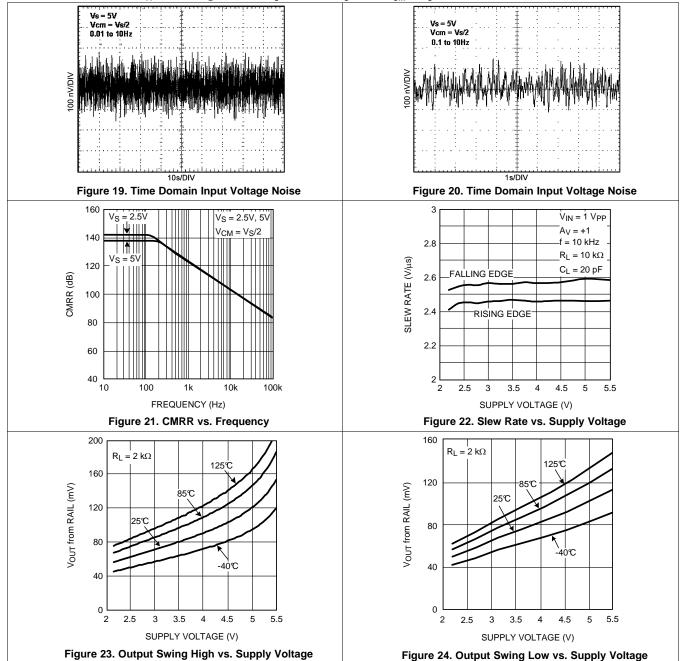
Unless otherwise noted:  $T_A = 25$ °C,  $R_L > 10$  k $\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5$  V,  $V_{CM} = V_S/2$ .



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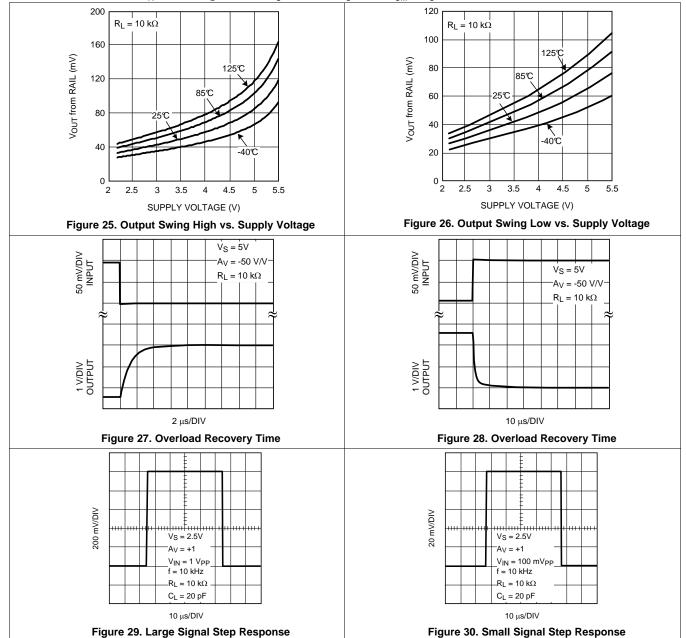


Unless otherwise noted:  $T_A = 25$ °C,  $R_L > 10$  k $\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5$  V,  $V_{CM} = V_S/2$ .



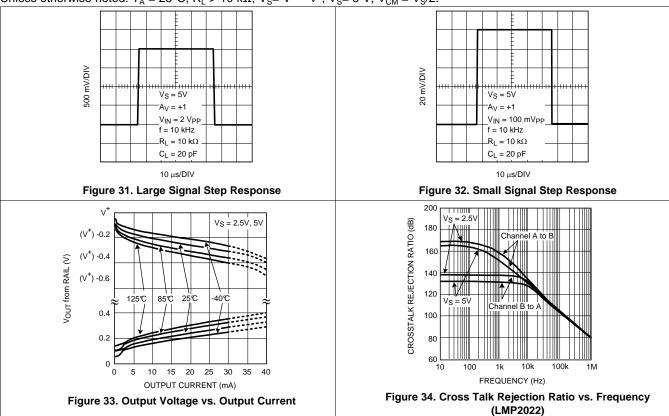


Unless otherwise noted:  $T_A = 25$ °C,  $R_L > 10$  k $\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5$  V,  $V_{CM} = V_S/2$ .





Unless otherwise noted:  $T_A = 25^{\circ}C$ ,  $R_L > 10~k\Omega$ ,  $V_S = V^+ - V^-$ ,  $V_S = 5~V$ ,  $V_{CM} = V_S/2$ .





# 7 Detailed Description

#### 7.1 Overview

The LMP202x are single and dual precision operational amplifiers with ultra low offset voltage, ultra low offset voltage drift, and very low input voltage noise with no 1/f and extended supply voltage range. The LMP202x offer on chip EMI suppression circuitry which greatly enhances the performance of these precision amplifiers in the presence of radio frequency signals and other high frequency disturbances.

The LMP202x utilize proprietary auto zero techniques to measure and continuously correct the input offset error voltage. The LMP202x have a DC input offset voltage with a maximum value of  $\pm 5~\mu V$  and an input offset voltage drift maximum value of 0.02  $\mu V/^{\circ}C$ . The input voltage noise of the LMP202x is less than 11  $nV/\sqrt{Hz}$  at a voltage gain of 1000 V/V and has no flicker noise component. This makes the LMP202x ideal for high accuracy, low frequency applications where lots of amplification is needed and the input signal has a very small amplitude.

The proprietary input offset correction circuitry enables the LMP202x to have superior CMRR and PSRR performances. The combination of an open loop voltage gain of 160 dB, CMRR of 142 dB, PSRR of 130 dB, along with the ultra low input offset voltage of only  $-0.4~\mu\text{V}$ , input offset voltage drift of only  $-0.004~\mu\text{V}/^{\circ}\text{C}$ , and input voltage noise of only 260 nV<sub>PP</sub> at 0.1 Hz to 10 Hz make the LMP202x great choices for high gain transducer amplifiers, ADC buffer amplifiers, DAC I-V conversion, and other applications requiring precision and long-term stability. Other features are rail-to-rail output, low supply current of 1.1 mA per amplifier, and a gain-bandwidth product of 5 MHz.

The LMP202x have an extended supply voltage range of 2.2 V to 5.5 V, making them ideal for battery operated portable applications. The LMP2021 is offered in 5-pin SOT-23 and 8-pin SOIC packages. The LMP2022 is offered in 8-pin VSSOP and 8-Pin SOIC packages.

# 7.2 Functional Block Diagram

#### 7.3 Feature Description

The amplifier's differential inputs consist of a non-inverting input (+IN) and an inverting input (-IN). The amplifier amplifies only the difference in voltage between the two inputs, which is called the differential input voltage. The output voltage of the op-amp Vout is given by Equation 1:

$$V_{OLIT} = A_{OL} \left( IN^+ - IN^- \right) \tag{1}$$

where A<sub>OL</sub> is the open-loop gain of the amplifier, typically around 100dB (100,000x, or 10uV per Volt).

#### 7.4 Device Functional Modes

#### 7.4.1 EMI Suppression

The near-ubiquity of cellular, Bluetooth, and Wi-Fi signals and the rapid rise of sensing systems incorporating wireless radios make electromagnetic interference (EMI) an evermore important design consideration for precision signal paths. Though RF signals lie outside the op amp band, RF carrier switching can modulate the DC offset of the op amp. Also some common RF modulation schemes can induce down-converted components. The added DC offset and the induced signals are amplified with the signal of interest and thus corrupt the measurement. The LMP202x use on chip filters to reject these unwanted RF signals at the inputs and power supply pins; thereby preserving the integrity of the precision signal path.

Product Folder Links: LMP2021 LMP2022



### **Device Functional Modes (continued)**

Twisted pair cabling and the active front-end's common-mode rejection provide immunity against low frequency noise (i.e. 60 Hz or 50 Hz mains) but are ineffective against RF interference. Figure 46 displays this. Even a few centimeters of PCB trace and wiring for sensors located close to the amplifier can pick up significant 1 GHz RF. The integrated EMI filters of LMP202x reduce or eliminate external shielding and filtering requirements, thereby increasing system robustness. A larger EMIRR means more rejection of the RF interference. For more information on EMIRR, please refer to AN-1698 (Literature Number SNOA497).

### 7.4.2 Input Voltage Noise

The input voltage noise density of the LMP202x has no 1/f corner, and its value depends on the feedback network used. This feature of the LMP202x differentiates this family from other products currently available from other vendors. In particular, the input voltage noise density decreases as the closed loop voltage gain of the LMP202x increases. The input voltage noise of the LMP202x is less than 11 nV/\(\bar{\text{Hz}}\) when the closed loop voltage gain of the op amp is 1000. Higher voltage gains are required for smaller input signals. When the input signal is smaller, a lower input voltage noise is quite advantageous and increases the signal to noise ratio.

Figure 35 shows the input voltage noise of the LMP202x as the closed loop gain increases.

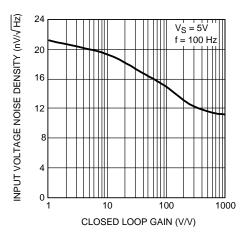


Figure 35. Input Voltage Noise Density decreases with Gain

Figure 36 shows the input voltage noise density does not have the 1/f component.

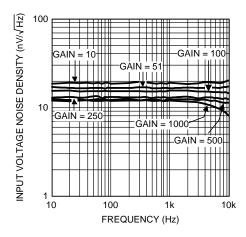


Figure 36. Input Voltage Noise Density with no 1/f

With smaller and smaller input signals and high precision applications with lower error budget, the reduced input voltage noise and no 1/f noise allow more flexibility in circuit design.

Product Folder Links: LMP2021 LMP2022



# 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 8.1 Application Information

### 8.1.1 Achieving Lower Noise With Filtering

The low input voltage noise of the LMP202x, and no 1/f noise make these suitable for many applications with noise sensitive designs. Simple filtering can be done on the LMP202x to remove high frequency noise. Figure 37 shows a simple circuit that achieves this.

In Figure 37 C<sub>F</sub> and the corner frequency of the filter resulting from C<sub>F</sub> and R<sub>F</sub> will reduce the total noise.

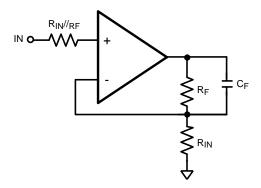


Figure 37. Noise Reducing Filter for Lower Gains

In order to achieve lower noise floors for even more noise stringent applications, a simple filter can be added to the op amp's output after the amplification stage. Figure 38 shows the schematic of a simple circuit which achieves this objective. Low noise amplifiers such as the LMV771 can be used to create a single pole low pass filter on the output of the LMP202x. The noise performance of the filtering amplifier, LMV771 in this circuit, will not be dominant as the input signal on LMP202x has already been significantly gained up and as a result the effect of the input voltage noise of the LMV771 is effectively not noticeable.

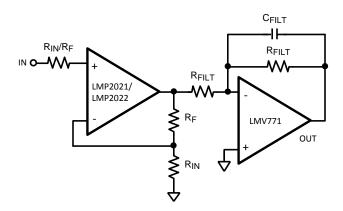


Figure 38. Enhanced Filter to Further Reduce Noise at Higher Gains



Using the circuit in Figure 38 has the advantage of removing the non-linear filter bandwidth dependency which is seen when the circuit in Figure 37 is used. The difference in noise performance of the circuits in Figure 37 and Figure 38 becomes apparent only at higher gains. At voltage gains of 10 V/V or less, there is no difference between the noise performance of the two circuits.

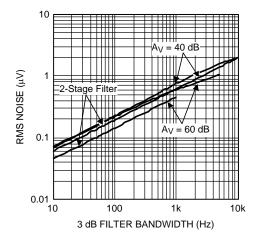


Figure 39. RMS Input Referred Noise vs. Frequency

Figure 39 shows the total input referred noise vs. 3 dB corner of both filters of Figure 37 and Figure 38 at gains of 100V/V and 1000V/V. For these measurements and using Figure 37's circuit,  $R_F = 49.7~k\Omega$  and  $R_{IN} = 497\Omega$ . Value of  $C_F$  has been changed to achieve the desired 3 dB filter corner frequency. In the case of Figure 38's circuit,  $R_F = 49.7~k\Omega$  and  $R_{IN} = 497\Omega$ ,  $R_{FILT} = 49.7~k\Omega$ , and  $C_{FILT}$  has been changed to achieve the desired 3 dB filter corner frequency. Figure 39 compares the RMS noise of these two circuits. As Figure 39 shows, the RMS noise measured the circuit in Figure 38 has lower values and also depicts a more linear shape.

#### 8.1.2 Input Bias Current

The bias current of the LMP202x behaves differently than a conventional amplifier due to the dynamic transient currents created on the input of an auto-zero circuit. The input bias current is affected by the charge and discharge current of the input auto-zero circuit. This effectivly creates a repetitive impulse current noise of 100's of pA. For this reason, the LMP202x is *not* recommeded for source impedances of 1  $M\Omega$  or greater.

The amount of current sunk or sourced from that stage is dependent on the combination of input impedance (resistance *and* capacitance), as well as the balance and matching of these impedances across the two inputs. This current, integrated by the input capacitence, causes a shift in the apparent "bias current". Because of this, there is an apparent "bias current vs. input impedance" interaction. In the LMP202x for an input resistive impedance of 1  $G\Omega$ , the shift in input bias current can be up to 40 pA. This input bias shift is caused by varying the input's capacitive impedance. Since the input bias current is dependent on the input impedance, it is difficult to estimate what the actual bias current is without knowing the end circuit and associated capacitive strays.

Figure 40 shows the input bias current of the LMP202x and that of another commercially available amplifier from a competitor. As it can be seen, the shift in LMP202x bias current is much lower than that of other chopper style or auto zero amplifiers available from other vendors.



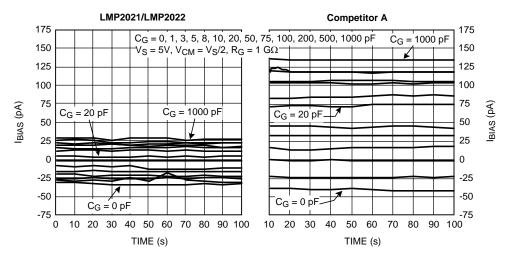


Figure 40. Input Bias Current of LMP202x is lower than Competitor A

#### 8.1.3 Lowering the Input Bias Current

As mentioned in the *Input Bias Current* section, the input bias current of an auto zero amplifier such as the LMP202x varies with input impedance and feedback impedance. Once the value of a certain input resistance, i.e. sensor resistance, is known, it is possible to optimize the input bias current for this fixed input resistance by choosing the capacitance value that minimizes that current. Figure 41 shows the input bias current vs. input impedance of the LMP202x. The value of  $R_G$  or input resistance in this test is 1  $G\Omega$ . When this value of input resistance is used, and when a parallel capacitance of 22 pF is placed on the circuit, the resulting input bias current is nearly 0 pA. Figure 41 can be used to extrapolate capacitor values for other sensor resistances. For this purpose, the total impedance seen by the input of the LMP202x needs to be calculated based on Figure 41. By knowing the value of  $R_G$ , one can calculate the corresponding  $C_G$  which minimizes the non-inverting input bias current, positive bias current, value.

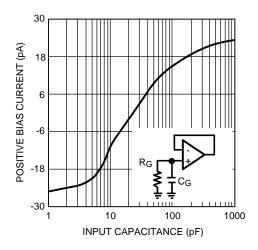


Figure 41. Input Bias Current vs.  $C_G$  with  $R_G = 1$   $G\Omega$ 

In a typical I-V converter, the output voltage will be the sum of DC offset plus bias current and the applied signal through the feedback resistor. In a conventional input stage, the inverting input's capacitance has very little effect on the circuit. This effect is generally on settling time and the dielectric soakage time and can be ignored. In auto zero amplifiers, the input capacitance effect will add another term to the output. This additional term means that the baseline reading on the output will be dependent on the input capacitance. The term input capacitance for this purpose includes circuit strays and any input cable capacitances. There is a slight variation in the capacitive

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offset as the duty cycle and amplitude of the pulses vary from part to part, depending on the correction at the time. The lowest input current will be obtained when the impedances, both resistive and capacitive, are matched between the inputs. By balancing the input capacitances, the effect can be minimized. A simple way to balance the input impedance is adding a capacitance in parallel to the feedback resistance. The addition of this feedback capacitance reduces the bias current and increases the stability of the operational amplifier. Figure 42 shows the input bias current of the LMP202x when  $R_F$  is set to 1  $G\Omega$ . As it can be seen from Figure 42, choosing the optimum value of  $C_F$  will help reducing the input bias current.

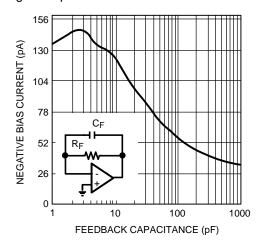


Figure 42. Input Bias Current vs.  $C_F$  with  $R_F = 1$   $G\Omega$ 

The effect of bias current on a circuit can be estimated with the following:

$$A_{V}^{*}I_{BIAS+}^{*}Z_{S} - I_{BIAS-}^{*}Z_{F}$$

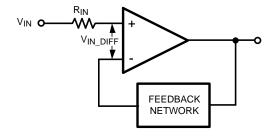
$$(2)$$

Where  $A_V$  is the closed loop gain of the system and  $I_{BIAS+}$  and  $I_{BIAS-}$  denote the positive and negative bias current, respectively. It is common to show the average of these bias currents in product datasheets. If  $I_{BIAS+}$  and  $I_{BIAS-}$  are not individually specified, use the  $I_{BIAS}$  value provided in datasheet graphs or tables for this calculation.

For the application circuit shown in Figure 46, the LMP2022 amplifiers each have a gain of 18. With a sensor impedance of  $500\Omega$  for the bridge, and using the above equation, the total error due to the bias current on the outputs of the LMP2022 amplifier will be less than 200 nV.

#### 8.1.4 Sensor Impedance

The sensor resistance, or the resistance connected to the inputs of the LMP202x, contributes to the total impedance seen by the auto correcting input stage.





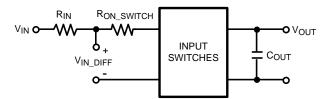


Figure 43. Auto Correcting Input Stage Model

As shown in Figure 43, the sum of  $R_{\text{IN}}$  and  $R_{\text{ON-SWITCH}}$  will form a low pass filter with  $C_{\text{OUT}}$  during correction cycles. As  $R_{\text{IN}}$  increases, the time constant of this filter increases, resulting in a slower output signal which could have the effect of reducing the open loop gain,  $A_{\text{VOL}}$ , of the LMP202x. In order to prevent this reduction in  $A_{\text{VOL}}$  in presence of high impedance sensors or other high resistances connected to the input of the LMP202x, a capacitor can be placed in parallel to this input resistance. This is shown in Figure 44.

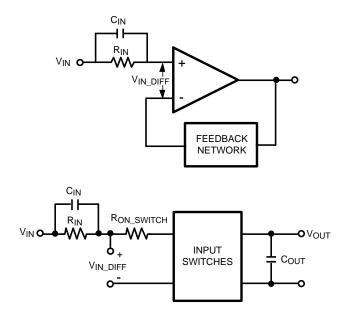


Figure 44. Sensor Impedance with Parallel Capacitance

 $C_{IN}$  in Figure 44 adds a zero to the low pass filter and hence eliminating the reduction in  $A_{VOL}$  of the LMP202x. An alternative circuit to achieve this is shown in Figure 45.

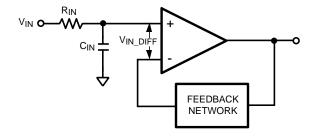


Figure 45. Alternative Sensor Impedance Circuit



#### 8.1.5 Transient Response to Fast Inputs

On chip continuous auto zero correction circuitry eliminates the 1/f noise and significantly reduces the offset voltage and offset voltage drift; all of which are very low frequency events. For slow changing sensor signals this correction is transparent. For excitations which may otherwise cause the output to swing faster than 40 mV/µs, there are additional considerations which can be viewed two perspectives: for sine waves and for steps.

For sinusoidal inputs, when the output is swinging rail-to-rail on ±2.5-V supplies, the auto zero circuitry will introduce distortions above 2.55 kHz. For smaller output swings, higher frequencies can be amplified without the auto zero slew limitation as shown in table below. Signals above 20 kHz, are not affected, though normally, closed loop bandwidth should be kept below 20 kHz so as to avoid aliasing from the auto zero circuit.

V <sub>OUT-PEAK</sub> (V)	f <sub>MAX-SINE</sub> WAVE (KHZ)
0.32	20
1	6.3
2.5	2.5

For step-like inputs, such as those arising from disturbances to a sensing system, the auto zero slew rate limitation manifests itself as an extended ramping and settling time, lasting ~100 µs.

### 8.1.6 Digital Acquisition Systems

High resolution ADC's with 16-bits to 24-bits of resolution can be limited by the noise of the amplifier driving them. The circuit configuration, the value of the resistors used and the source impedance seen by the amplifier can affect the noise of the amplifier. The total noise at the output of the amplifier can be dominated by one of several sources of noises such as: white noise or broad band noise, 1/f noise, thermal noise, and current noise. In low frequency applications such as medical instrumentation, the source impedance is generally low enough that the current noise coupled into it does not impact the total noise significantly. However, as the 1/f or flicker noise is paramount to many application, the use of an auto correcting stabilized amplifier like the LMP202x reduces the total noise.

Table 1 summarizes the input and output referred RMS noise values for the LMP202x compared to that of Competitor A. As described in previous sections, the outstanding noise performance of the LMP202x can be even further improved by adding a simple low pass filter following the amplification stage.

The use of an additional filter, as shown in Figure 38 benefits applications with higher gain. For this reason, at a gain of 10, only the results of circuit in Figure 37 are shown. The RMS input noise of the LMP202x are compared with Competitor A's input noise performance. Competitor A's RMS input noise behaves the same with or without an additional filter.

**Table 1. RMS Input Noise Performance** 

Amplifier		RMS Input Noise (nV)							
Gain (V/V)	System Bandwidth Requirement (Hz)	LMP	Competitor A						
	(/	Figure 37 Circuit	Figure 38 Circuit	Figure 37, Figure 38 Circuit					
10	100	229	See <sup>(1)</sup>	300					
10	1000	763	See <sup>(1)</sup>	1030					
400	100	229	196	300					
100	1000	763	621	1030					
	10	71	46	95					
1000	100	158	146	300					
	1000	608	462	1030					

(1) No significant difference in Noise measurements at  $A_V = 10V/V$ 



#### 8.2 Typical Application

Figure 46 shows the Bridge Sensor Interface for these devices.

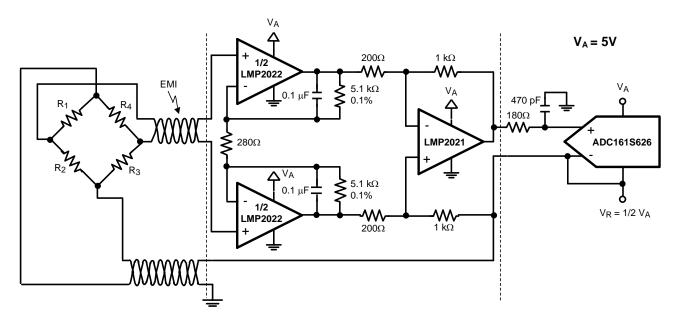


Figure 46. LMP202x Used With ADC161S626

### 8.2.1 Design Requirements

Bridge sensors are used in a variety of applications such as pressure sensors and weigh scales. Bridge sensors typically have a very small differential output signal. This very small differential signal needs to be accurately amplified before it can be fed into an ADC. As discussed in the previous sections, the accuracy of the op amp used as the ADC driver is essential to maintaining total system accuracy.

The high DC performance of the LMP202x make these amplifiers ideal choices for use with a bridge sensor. The LMP202x have very low input offset voltage and very low input offset voltage drift. The open loop gain of the LMP202x is 160 dB.

The circuit in Figure 46 shows a signal path solution for a typical bridge sensor using the LMP202x. Bridge sensors are created by replacing at least one of the resistors in a typical bridge with a sensor whose resistance varies in response to an external stimulus. For this example, the expected bridge output signal will be in the range of ±12 mV. This signal must be accurately amplified by the amplifier to best match the dynamic input range of the ADC. This is done by using one LMP2022 and one LMP2021 in front of the ADC161S626.

The on chip EMI rejection filters available on the LMP202x help remove the EMI interference introduced to the signal and hence improve the overall system performance.

#### 8.2.2 Detailed Design Procedure

The amplification of this ±12 mV signal is achieved in 2 stages and through a three op-amp instrumentation amplifier. The dual LMP2022 in Figure 46 amplifies each side of the differential output of the bridge sensor by a gain of 18.2. Using the LMP2022 with a gain of 18.2 reduces the input referred voltage noise of the op amps and the system as a result. Also, this gain allows direct filtering of the signal on the LMP2022 without compromising noise performance. The differential output of the two amplifiers in the LMP2022 are then fed into a LMP2021 configured as a difference amplifier. This stage has a gain of 5, with a total system having a gain of (18.2 \* 2 + 1) \* 5 = 187. The LMP2021 has an outstanding CMRR value of 139. This impressive CMRR improves system performance by removing the common mode signal introduced by the bridge. With an overall gain of 187, the ±12 mV differential input signal is gained up to ±2.24V (0.26 V to 4.74V single ended). This utilizes the amplifiers output swing as well as the ADC's input dynamic range, and allows for some overload range.

Product Folder Links: LMP2021 LMP2022



# **Typical Application (continued)**

Bridge sensor measurements are usually done up to 10s of Hz. Placing a 300 Hz filter on the LMP2022 helps removing the higher frequency noise from this circuit. This filter is created by placing two capacitors in the feedback path of the LMP2022 amplifiers.

This amplified signal is then fed into the ADC161S626. The ADC161S626 is a 16-bit, 50 kSPS to 250 kSPS 5V ADC. In order to utilize the maximum number of bits of the ADC161S626 in this configuration, a 2.5V reference voltage is used. This 2.5V reference is also used to power the bridge sensor and the inverting input of the ADC. Using the same voltage source for these three points helps reducing the total system error by eliminating error due to source variations.

With this system, the output signal of the bridge sensor which can be up to ±13.3 mV and is accurately scaled to the full scale range of the ADC and then digitized for further processing. The LMP202x introduced minimal error to the system and improved the signal quality by removing common mode signals and high frequency noise.

### 8.2.3 Application Curve

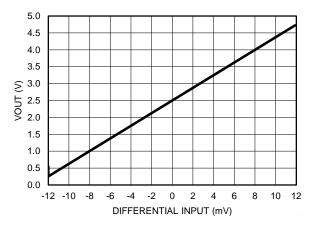


Figure 47. Single Ended Output Results for Bridge Circuit

# 9 Power Supply Recommendations

The LMP202x is specified for operation from 2.2 V to 5.5 V (±1.1 V to ±2.75 V) over a -40°C to +125°C temperature range. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

#### **CAUTION**

Supply voltages larger than 6 V can permanently damage the device.

# 10 Layout

#### 10.1 Layout Guidelines

For best operational performance of the device, use good printed circuit board (PCB) layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and op amp itself.
   Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
- Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close
  to the device as possible. A single bypass capacitor from V+ to ground is applicable for single supply
  applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective

Product Folder Links: LMP2021 LMP2022

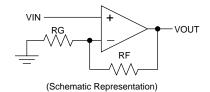


### **Layout Guidelines (continued)**

methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current. For more detailed information refer to SLOA089, *Circuit Board Layout Techniques*.

- In order to reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If it is not possible to keep them separate, it is much better to cross the sensitive trace perpendicular as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in *Typical Characteristics*, keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

# 10.2 Layout Example



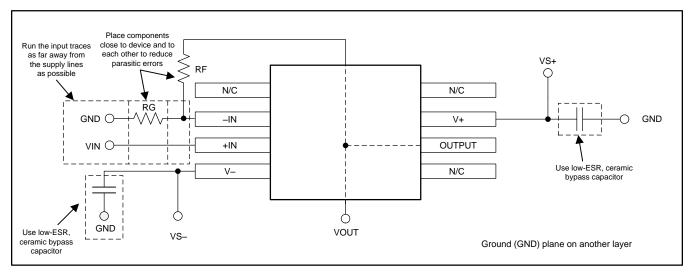


Figure 48. Operational Amplifier Board Layout for Noninverting Configuration



# 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Development Support

LMP2021/22 PSPICE Model, SNOM100

TINA-TI SPICE-Based Analog Simulation Program, http://www.ti.com/tool/tina-ti

TI Filterpro Software, http://www.ti.com/tool/filterpro

DIP Adapter Evaluation Module, http://www.ti.com/tool/dip-adapter-evm

TI Universal Operational Amplifier Evaluation Module, http://www.ti.com/tool/opampevm

Manual for LMH730268 Evaluation board 551012922-001

# 11.2 Documentation Support

#### 11.2.1 Related Documentation

SBOA015 (AB-028) — Feedback Plots Define Op Amp AC Performance.

SLOA089 — Circuit Board Layout Techniques.

SLOD006 — Op Amps for Everyone.

SNOA497 — AN-1698 A Specification for EMI Hardened Operational Amplifiers.

SBOA128 — EMI Rejection Ratio of Operational Amplifiers.

TIPD128 — Capacitive Load Drive Solution using an Isolation Resistor.

SBOA092 -— Handbook of Operational Amplifier Applications.

#### 11.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 2. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LMP2021	Click here	Click here	Click here	Click here	Click here
LMP2022	Click here	Click here	Click here	Click here	Click here

#### 11.4 Trademarks

LMP is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

Product Folder Links: LMP2021 LMP2022



# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: LMP2021 LMP2022





17-Feb-2016

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LMP2021MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMP20 21MA	Samples
LMP2021MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMP20 21MA	Samples
LMP2021MF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AF5A	Samples
LMP2021MFE/NOPB	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AF5A	Samples
LMP2021MFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AF5A	Samples
LMP2022MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMP20 22MA	Samples
LMP2022MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMP20 22MA	Samples
LMP2022MM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AV5A	Samples
LMP2022MME/NOPB	ACTIVE	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AV5A	Samples
LMP2022MMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AV5A	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



# **PACKAGE OPTION ADDENDUM**

17-Feb-2016

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE MATERIALS INFORMATION

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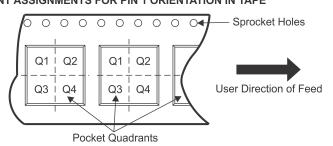
# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMP2021MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMP2021MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMP2021MFE/NOPB	SOT-23	DBV	5	250	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMP2021MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMP2022MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMP2022MM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMP2022MME/NOPB	VSSOP	DGK	8	250	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMP2022MMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMP2021MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMP2021MF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMP2021MFE/NOPB	SOT-23	DBV	5	250	210.0	185.0	35.0
LMP2021MFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LMP2022MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMP2022MM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LMP2022MME/NOPB	VSSOP	DGK	8	250	210.0	185.0	35.0
LMP2022MMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4073253/P







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Reference JEDEC MO-178.





NOTES: (continued)

- 4. Publication IPC-7351 may have alternate designs.
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Reference JEDEC MO-178.





NOTES: (continued)

- 4. Publication IPC-7351 may have alternate designs.
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.



# D (R-PDSO-G8)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



# DGK (S-PDSO-G8)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



# DGK (S-PDSO-G8)

# PLASTIC SMALL OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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